TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7MBD3244AFK

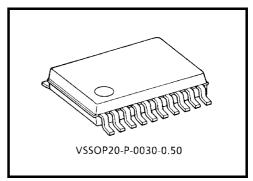
#### Octal Bus Switch

The TC7MBD3244AFK provides eight bits of high-speed TTL-compatible bus switching in a standard '244 device pinout. The low on resistance of the switch allows connections to be made with minimal propagation delay.

The device is organized as two 4-bit low-impedance switches with separate output-enable  $(\overline{OE})$  inputs. When  $\overline{OE}$  is low, the switch is on and data can flow from port A to port B, or vice versa. When  $\overline{OE}$  is high, the switch is open and a high-impedance state exists between the two ports.

The device is enable to realize the shift of signal level from 5 V to 3.3 V.

All inputs are equipped with protection circuits against static discharge.

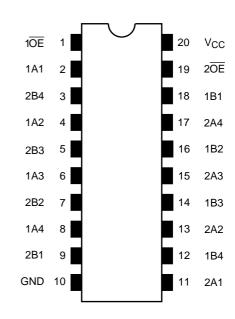


Weight: 0.03 g (typ.)

#### **Features**

- Operating voltage:  $V_{CC} = 4.5 \sim 5.5 \text{ V}$
- High speed:  $t_{pd} = 0.32 \text{ ns (max.)}$
- Low on resistance:  $RON = 5 \Omega$  (typ.)
- ESD performance: Human body model >  $\pm 2000 \text{ V}$ Machine model >  $\pm 200 \text{ V}$
- Compatible with TTL outputs (control inputs)
- Low Power Dissipation: Icc = 10 μA (max.)
- Package: VSSOP (US20)
- Pin compatible with the 74xx244 type. Functionally equivalent to (FST/CBT) 3244.

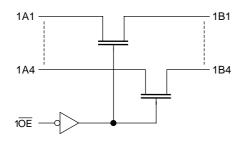
## Pin Assignment (top view)

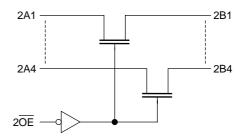


## **Truth Table**

Inputs	Function		
ŌĒ	Function		
L	A port = B port		
Н	Disconnect		

# **System Diagram**





# **Maximum Ratings**

Characteristics	Symbol	Rating	Unit
Power supply range	V <sub>CC</sub>	-0.5~7.0	V
DC input voltage	V <sub>IN</sub>	-0.5~7.0	V
DC switch voltage	Vs	-0.5~7.0	V
Input diode current	I <sub>IK</sub>	-50	mA
Continuous channel circuit	IS	128	mA
Power dissipation	PD	180	mW
DC V <sub>CC</sub> /ground current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65~150	°C

# **Recommended Operating Conditions**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	4.5~5.5	V
Input voltage	V <sub>IN</sub>	0~5.5	V
Switch voltage	Vs	0~5.5	V
Operating temperature	T <sub>opr</sub>	-40~85	°C
Input rise and fall time	dt/dv	0~10	ns/V

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#### **Electrical Characteristics**

## DC Characteristics ( $Ta = -40 \sim 85$ °C)

Charac	cteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Typ. (Note 1)	Max	Unit
Innut voltage	"H" level	$V_{IH}$	_		4.5~5.5	2.0	_	_	V
Input voltage	"L" level	V <sub>IL</sub>	_	-	4.5~5.5	_	_	0.8	V
High lovel outp	ut voltogo		IOH=-1μA V <sub>IS</sub> = V <sub>CC</sub>		4.75	2.3	2.8	3.2	٧
High-level outp	(Note 2)	$V_{OH}$			5.0	2.5	3.0	3.4	
	(Note 2)		VIS – VCC		5.25	2.7	3.2	3.6	
Input leakage of	current	I <sub>IN</sub>	V <sub>IN</sub> = 0~5.5 V		4.5~5.5	_	_	±1.0	μΑ
Power off leak	age current	l <sub>OFF</sub>	A, B, $\overline{OE}$ = 0~5.5 V		0	_	_	±1.0	μΑ
Off-STATE lea	kage current	I <sub>SZ</sub>	A, B = $0 \sim 5.5 \text{ V}$ , $\overline{\text{OE}} = \text{V}_{\text{CC}}$		4.5~5.5	_	_	±1.0	μΑ
			I <sub>IS</sub> = 64 mA	4.5	_	5	9		
			V <sub>IS</sub> = 0 V	IIS – 04 IIIA	4.75	_	5	8	Ω
ON resistance		Pou		I <sub>IS</sub> = 30 mA	4.5	_	5	9	
	(Note 3)	) R <sub>ON</sub>			4.75	_	5	8	
		V 22V L 45	^	4.5	_	35	65		
		$V_{IS} = 2.3 \text{ V}, I_{IS} = 15 \text{ mA}$		4.75	_	35	50		
Quiescent supp	oly current	Icc	$V_{IN} = V_{CC}$ or $GND, I_{OUT} = 0$		5.5	_	_	10	μА
Increase in I <sub>CC</sub>	per input	Δlcc	V <sub>IN</sub> = 3.4 V (one input)		5.5	_	_	2.5	mA

Note 1: Typical values are at  $V_{CC} = 5 \text{ V}$ ,  $Ta = 25^{\circ}\text{C}$ .

Note 2: It recommends that this device uses Pull-up resistance when adding and using resistance for an output terminal. Since it couses to drop a VOH voltage level when using Pull-down resistance for an output terminal.

Note 3: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

## AC Characteristics ( $Ta = -40 \sim 85$ °C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Propagation delay time (bus to bus)	t <sub>pLH</sub>	Figure 1, Figure 2 (Note 4)	4.5	_	0.32	ns
Output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	4.5		7.0	ns
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	4.5	_	7.0	ns

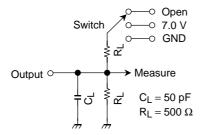
Note 4: The propagation delay time is calculated by the RC (on-resistance and load capacitance) time constant.

## **Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Control pin input capacitance	C <sub>IN</sub>	(Note 5)	5.0	3	pF
Switch terminal capacitance	C <sub>I/O</sub>	$\overline{OE} = V_{CC}$ (Note 5)	5.0	10	pF

Note 5: This parameter is guaranteed by design.

#### **AC Test Circuit**



Parameter	Switch		
t <sub>pLH</sub> , t <sub>pHL</sub>	Open		
t <sub>pLZ</sub> , t <sub>pZL</sub>	7.0 V		
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND		

Figure 1

#### **AC Waveform**

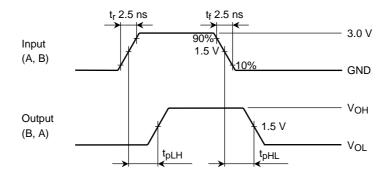


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>

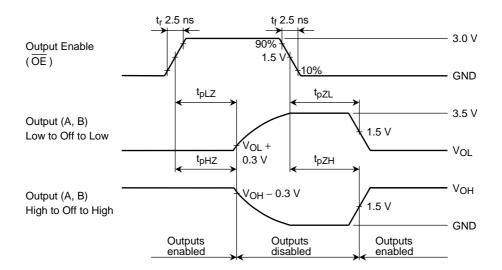
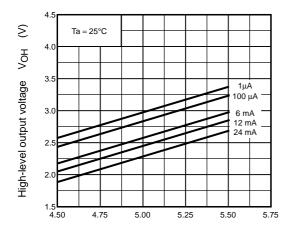
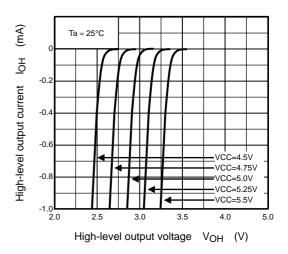
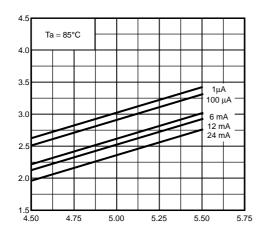


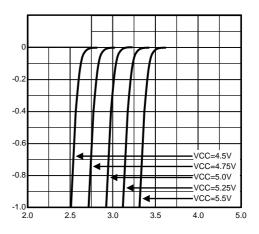
Figure 3  $t_{pLZ}, t_{pHZ}, t_{pZL}, t_{pZH}$ 

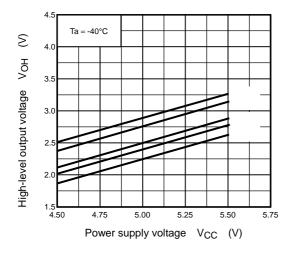
## V<sub>OH</sub> – V<sub>CC</sub> Characteristics (typ.)











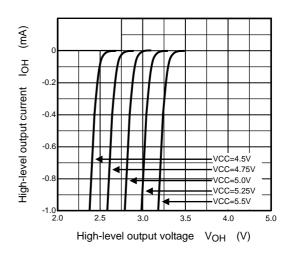
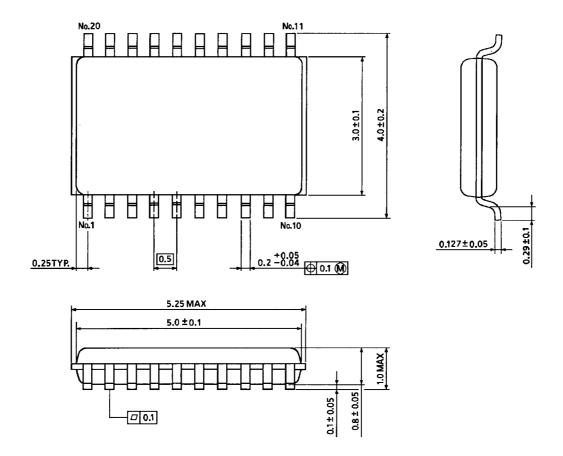


Figure 4

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## **Package Dimensions**



Weight: 0.03 g (typ.)

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